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#### Boomer® Audio Power Amplifier Series Integrated Audio Amplifier System LM4855

Check for Samples: LM4855

#### **FEATURES**

- 1.1W (typ) Output Power with 8Ω Mono BTL
- 115mW (typ) Output Power with Stereo 32Ω **BTL Loads**
- SPI Programmable 32 Step Digital Volume Control
- **Eight Distinct Output Modes**
- **DSBGA and WQFN Surface Mount Packaging**
- "Click and Pop" Suppression Circuitry
- Thermal Shutdown Protection
- Low Shutdown Current (0.1uA, typ)

#### **KEY SPECIFICATIONS**

- THD+N at 1kHz, 1.1W into  $8\Omega$  BTL: 1.0% (typ)
- THD+N at 1kHz, 115mW into 32Ω BTL: 0.5% (typ)
- Single Supply Operation: 2.6 to 5.0V

#### **APPLICATIONS**

- **Moblie Phones**
- **PDAs**

#### DESCRIPTION

The LM4855 is an audio power amplifier system capable of delivering 1.1W (typ) of continuous average power into a mono 8Ω bridged-tied load (BTL) with 1% THD+N and 115mW (typ) per channel of continuous average power into stereo 32Ω BTL loads with 0.5% THD+N, using a 5V power supply.

The LM4855 features a 32 step digital volume control and eight distinct output modes. The digital volume control and output modes are programmed through a three-wire SPI serial control interface, that allows flexibility in routing and mixing audio channels.

The LM4855 is designed for cellular phone, PDA, and other portable handheld applications. It delivers high quality output power from a surface-mount package and requires only six external components.

The industry leading DSBGA package only utilizes 2mm x 2.3mm of PCB space, making the LM4855 the most space efficient audio sub system available today.

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# **Typical Application**

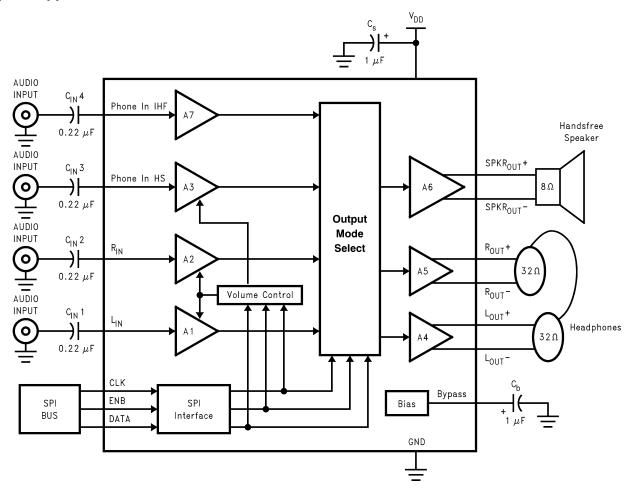


Figure 1. Typical Audio Amplifier Application Circuit



## **Connection Diagrams**

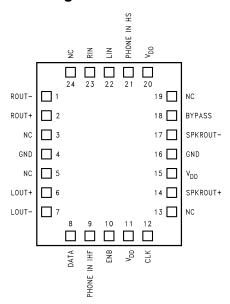


Figure 2. WQFN Package Top View See Package Number NHW0024A for Exposed-DAP WQFN

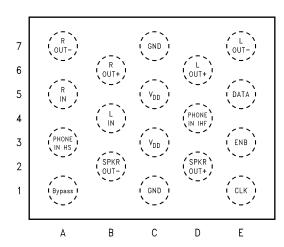


Figure 3. Top View (Bump-Side Down) See Package Number YZR0018AAA





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# **Absolute Maximum Ratings**(1)(2)

, 110 C C 1 C 1 C 1 1 1 C 1 1 1 1 C 1 1 1 1	,-		
Supply Voltage		6.0V	
Storage Temperature		−65°C to +150°C	
ESD Susceptibility <sup>(3)</sup>		2.0kV	
ESD Machine model <sup>(4)</sup>	200V		
Junction Temperature (T <sub>J</sub> )	150°0		
Solder Information	Vapor Phase (60 sec.)	215°C	
	Infrared (15 sec.)	220°C	
	θ <sub>JA</sub> (typ) - NHW0024A	42°C/W	
Thermal Resistance	$\theta_{JC}$ (typ) - NHW0024A	3.0°C/W	
Thermal Resistance	θ <sub>JA</sub> (typ) - YZR0018AAA	48°C/W <sup>(5)</sup>	
	θ <sub>JC</sub> (typ) - YZR0018AAA	23°C/W <sup>(5)</sup>	

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) Human body model, 100pF discharged through a 1.5kΩ resistor.
- (4) Machine Model ESD test is covered by specification EIAJ IC-121-1981. A 200pF cap is charged to the specified voltage, then discharged directly into the IC with no external series resistor (resistance of discharge path must be under 50Ω).
- (5) The given θ<sub>JA</sub> and θ<sub>JC</sub> are for an LM4855 mounted on a demonstration board with a 4in² area of 1oz printed circuit board copper ground plane.

# Operating Ratings<sup>(1)</sup>

Temperature Range	-40°C to 85°C
Supply Voltage V <sub>DD</sub>	2.6V ≤ V <sub>DD</sub> ≤ 5.0V

(1) Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.



# 5V Electrical Characteristics (1)(2)

The following specifications apply for V<sub>DD</sub>= 5.0V, T<sub>A</sub>= 25°C unless otherwise specified.

Symbol	Parameter	Conditions	LM4	Units	
			Typical	Limits (4)	(Limits)
		Output mode 1 V <sub>IN</sub> = 0V; No loads	5.7	8	mA (max)
I <sub>DD</sub>	County County	Output mode 1 V <sub>IN</sub> = 0V; Loaded (Fig.1)	6.7	9	mA (max)
	Supply Current	Output modes 2, 3, 4, 5, 6, 7 V <sub>IN</sub> = 0V; No loads	7.5	11	mA (max)
		Output modes 2, 3, 4, 5, 6, 7 V <sub>IN</sub> = 0V; Loaded (Fig. 1)	8.5	12	mA (max)
I <sub>SD</sub>	Shutdown Current	Output mode 0	0.1	2.0	μA (max)
Vos	Output Offset Voltage	V <sub>IN</sub> = 0V	5.0	40	mV (max)
		SPKR <sub>OUT</sub> ; $R_L = 4\Omega$ THD+N = 1%; $f = 1$ kHz, LM4855LQ	1.5		W
P <sub>O</sub>	Output Power	SPKR <sub>OUT</sub> ; $R_L = 8\Omega$ THD+N = 1%; $f = 1kHz$	1.1	0.8	W (min)
		$R_{OUT}$ and $L_{OUT}$ ; $R_L = 32\Omega$ THD+N = 0.5%; f = 1kHz	115	70	mW (min)
	Total Harmania Diatartian Diva Naisa	$SPKR_{OUT}$ $f = 20Hz \text{ to } 20kHZ$ $P_{OUT} = 400mW; R_L = 8\Omega$	0.5		%
THD+N	Total Harmonic Distortion Plus Noise	$R_{OUT}$ and $L_{OUT}$ f = 20Hz to 20kHZ $P_{OUT}$ = 50mW; $R_L$ = 32 $\Omega$	0.5		%
N <sub>OUT</sub>	Output Noise	A-weighted <sup>(5)</sup>	29		μV
PSRR	Power Supply Rejection Ratio SPKR <sub>OUT</sub>	$V_{RIPPLE}$ = 200m $V_{PP}$ ; f = 217Hz, $C_B$ = 1.0 $\mu$ F All audio inputs terminated into 50 $\Omega$ ; Output referred Gain (BTL) = 12dB Output Mode 1, 3, 5, 7	57	54	dB (min)
	Dawer Cumby Dejection Detic	$V_{RIPPLE} = 200 mV_{PP}; f = 217 Hz, C_B = 1.0 \mu F$ All audio inputs terminated into $50 \Omega;$ Output referred Maximum gain setting			
	Power Supply Rejection Ratio R <sub>OUT</sub> and L <sub>OUT</sub>	Output Mode 2, 3	62	59	dB (min)
		Output Mode 4, 5	57	54	dB (min)
		Output Mode 6, 7	54	51	dB (min)
V <sub>IH</sub>	Logic High Input Voltage			1.4 V <sub>DD</sub>	V (min) V (max)
$V_{IL}$	Logic Low Input Voltage			0.4 GND	V (max) V (min)

<sup>(1)</sup> Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

<sup>(2)</sup> All voltages are measured with respect to the ground pin, unless otherwise specified.

<sup>(3)</sup> Typical specifications are specified at +25°C and represent the most likely parametric norm.

<sup>(4)</sup> Tested limits are guaranteed to TI's AOQL (Average Outgoing Quality Level).

<sup>(5)</sup> Please refer to the Output Noise vs Output Mode table in the Typical Performance Characteristics section for more details.



# 5V Electrical Characteristics<sup>(1)(2)</sup> (continued)

The following specifications apply for  $V_{DD}$ = 5.0V,  $T_A$ = 25°C unless otherwise specified.

Symbol	Parameter	Conditions	LM4	Units	
			Typical	Limits (4)	(Limits)
	Digital Volume Range ( $R_{\rm IN}$ and $L_{\rm IN}$ )	Input referred minimum gain	-34.5	-35.1 -33.9	dB (min) dB (max)
		Input referred maximum gain	12.0	11.4 12.6	dB (min) dB (max)
	Digital Volume Stepsize		1.5		dB
	Digital Volume Stepsize Error		±0.1	±0.6	dB ( max)
	Phone_In_IHF Volume	BTL gain from Phone_In _IHF to SPKR <sub>OUT</sub>	12	11.4 12.6	dB (min) dB (max)
	Phone _In_IHF Mute Attenuation	Output Mode 2, 4, 6	80	72	dB (min)
	Phone_In_IHF Input Impedance		20	15 25	kΩ (min) kΩ (max)
	Phone_In_HS Input Impedance  R <sub>IN</sub> and L <sub>IN</sub> Input Impedance	Maximum gain setting	50	37.5 62.5	kΩ (min) kΩ (max)
		Mininum gain setting	100	75 125	kΩ (min) kΩ (max)
		Maximum gain setting	33.5	25 42	kΩ (min) kΩ (max)
		Mininum gain setting	100	75 125	kΩ (min) kΩ (max)
SD	Thermal Shutdown Temperature		170	150	°C (min)
ES	Enable Setup Time (ENB)			20	ns (min)
EH	Enable Hold Time (ENB)			20	ns (min)
EL	Enable Low Time (ENB)			30	ns (min)
t <sub>DS</sub>	Data Setup Time (DATA)			20	ns (min)
t <sub>DH</sub>	Data Hold Time (DATA)			20	ns (min)
tcs	Clock Setup Time (CLK)			20	ns (min)
СН	Clock Logic High Time (CLK)			50	ns (min)
t <sub>CL</sub>	Clock Logic Low Time (CLK)			50	ns (min)
CLK	Clock Frequency			DC 10	(min) MHz (max)



# 3V Electrical Characteristics (1)(2)

The following specifications apply for  $V_{DD}$ = 3.0V,  $T_A$ = 25°C unless otherwise specified.

Symbol	Parameter	Conditions	LM4	Units	
			Typical	Limits (4)	(Limits)
		Output mode 1 V <sub>IN</sub> = 0V; No loads	4.5	7	mA (max)
I <sub>DD</sub>	Council of Council	Output mode 1 V <sub>IN</sub> = 0V; Loaded (Fig.1)	5.0	8	mA (max)
	Supply Current	Output modes 2, 3, 4, 5, 6, 7 V <sub>IN</sub> = 0V; No loads	6.5	10	mA (max)
		Output modes 2, 3, 4, 5, 6, 7 V <sub>IN</sub> = 0V; Loaded (Fig. 1)	7	11	mA (max)
I <sub>SD</sub>	Shutdown Current	Output mode 0	0.1	2.0	μA (max)
Vos	Output Offset Voltage	$V_{IN} = 0V$	5.0	40	mV (max)
		SPKR <sub>OUT</sub> ; $R_L = 4\Omega$ THD+N = 1%; $f = 1$ kHz, LM4855LQ	430		mW
P <sub>O</sub>	Output Power	SPKR <sub>OUT</sub> ; $R_L = 8\Omega$ THD+N = 1%; $f = 1kHz$	340	300	mW (min)
		$R_{OUT}$ and $L_{OUT}$ ; $R_L = 32\Omega$ THD+N = 0.5%; f = 1kHz	25	20	mW (min)
THD+N	Total Harmonic Distortion Plus Noise	$SPKR_{OUT} \\ f = 20Hz \text{ to } 20kHZ \\ P_{OUT} = 250mW; R_L = 8\Omega$	0.5		%
	Total Harmonic Distortion Flus Noise	$\begin{aligned} &R_{OUT} \text{ and } L_{OUT} \\ &f = 20 \text{Hz to } 20 \text{kHZ} \\ &P_{OUT} = 20 \text{mW}; \ R_L = 32 \Omega \end{aligned}$	0.5		%
N <sub>OUT</sub>	Output Noise	A-weighted <sup>(5)</sup>	29		μV
	Power Supply Rejection Ratio SPKR <sub>OUT</sub>	$V_{RIPPLE} = 200 mV_{PP}; f = 217 Hz, C_B = 1.0 \mu F$ All audio inputs terminated into $50 \Omega;$ Output referred Gain (BTL) = 12dB Output Mode 1, 3, 5, 7	58	55	dB (min)
PSRR	Power Supply Rejection Ratio R <sub>OUT</sub> and L <sub>OUT</sub>	$V_{RIPPLE} = 200 mV_{PP}; f = 217 Hz, C_B = 1.0 \mu F$ All audio inputs terminated into $50 \Omega;$ Output referred Maximum gain setting			
		Output Mode 2, 3	63	60	dB (min)
		Output Mode 4, 5	58	55	dB (min)
		Output Mode 6, 7	55	52	dB (min)
V <sub>IH</sub>	Logic High Input Voltage			1.4 V <sub>DD</sub>	V (min) V (max)
V <sub>IL</sub>	Logic Low Input Voltage			0.4 GND	V (max) V (min)

<sup>(1)</sup> Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.

<sup>(2)</sup> All voltages are measured with respect to the ground pin, unless otherwise specified.

<sup>(3)</sup> Typical specifications are specified at +25°C and represent the most likely parametric norm.

<sup>4)</sup> Tested limits are guaranteed to TI's AOQL (Average Outgoing Quality Level).

<sup>5)</sup> Please refer to the Output Noise vs Output Mode table in the Typical Performance Characteristics section for more details.



# 3V Electrical Characteristics<sup>(1)(2)</sup> (continued)

The following specifications apply for  $V_{DD}$ = 3.0V,  $T_A$ = 25°C unless otherwise specified.

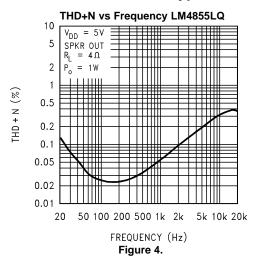
Symbol	Parameter	Conditions	LM4	Units	
			Typical (3)	Limits (4)	(Limits)
	Digital Values Dance (D. cod I.)	Input referred minimum gain	-34.5	-35.1 -33.9	dB (min) dB (max)
	Digital Volume Range (R <sub>IN</sub> and L <sub>IN</sub> )	Input referred maximum gain	12.0	11.4 12.6	dB (min) dB (max)
	Digital Volume Stepsize		1.5		dB
	Digital Volume Stepsize Error		±0.1	±0.6	dB ( max)
	Phone_In_IHF Volume	BTL gain from Phone_In _IHF to SPKR <sub>OUT</sub>	12	11.4 12.6	dB (min) dB (max)
	Phone _In_IHF Mute Attenuation	Output Mode 2, 4, 6	80	72	dB (min)
	Phone_In_IHF Input Impedance		20	15 25	kΩ (min) kΩ (max)
	Phone_In_HS Input Impedance  R <sub>IN</sub> and L <sub>IN</sub> Input Impedance	Maximum gain setting	50	37.5 62.5	kΩ (min) kΩ (max)
		Mininum gain setting	100	75 125	kΩ (min) kΩ (max)
		Maximum gain setting	33.5	25 42	kΩ (min) kΩ (max)
		Mininum gain setting	100	75 125	kΩ (min) kΩ (max)
t <sub>SD</sub>	Thermal Shutdown Temperature		170	150	°C (min)
t <sub>ES</sub>	Enable Setup Time (ENB)			20	ns (min)
t <sub>EH</sub>	Enable Hold Time (ENB)			20	ns (min)
t <sub>EL</sub>	Enable Low Time (ENB)			30	ns (min)
t <sub>DS</sub>	Data Setup Time (DATA)			20	ns (min)
t <sub>DH</sub>	Data Hold Time (DATA)			20	ns (min)
t <sub>CS</sub>	Clock Setup Time (CLK)			20	ns (min)
t <sub>CH</sub>	Clock Logic High Time (CLK)			50	ns (min)
t <sub>CL</sub>	Clock Logic Low Time (CLK)			50	ns (min)
f <sub>CLK</sub>	Clock Frequency			DC 10	(min) MHz (max)

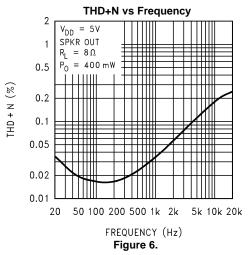
**External Components Description** 

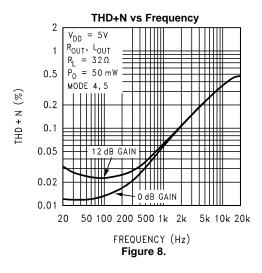
Components		Functional Description
1.	C <sub>IN</sub>	This is the input coupling capacitor. It blocks the DC voltage and couples the input signal to the amplifier's input terminals. $C_{IN}$ also creates a highpass filter with the internal resistor $R_{i}$ (Input Impedance) at $f_{c} = 1/(2\pi R_{i}C_{IN})$ .
2.	C <sub>S</sub>	This is the supply bypass capacitor. It filters the supply voltage applied to the V <sub>DD</sub> pin and helps maintain the LM4855's PSRR.
3.	C <sub>B</sub>	This is the BYPASS pin capacitor. It filters the V <sub>DD</sub> / 2 voltage and helps maintain the LM4855's PSRR.

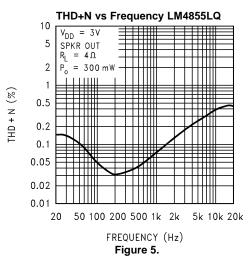


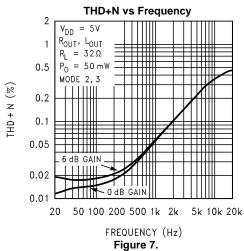
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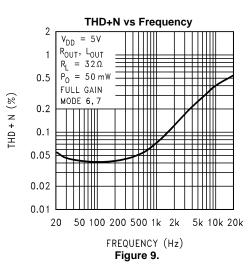




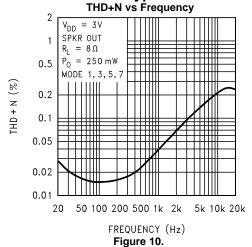


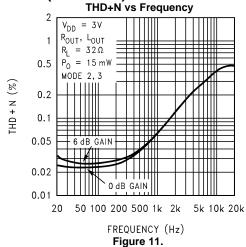


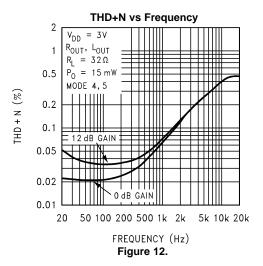


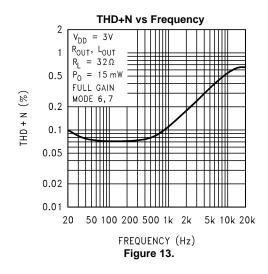


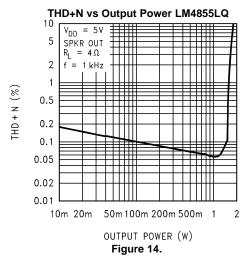


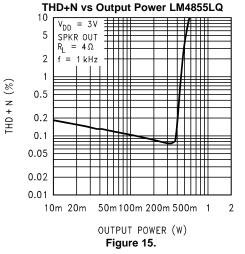




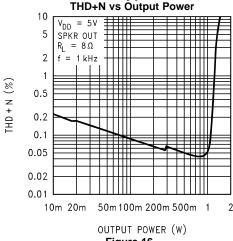




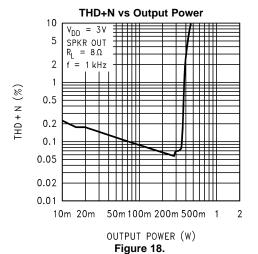


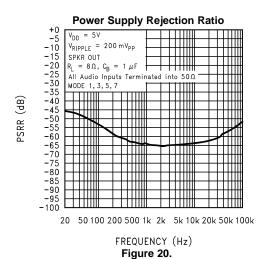


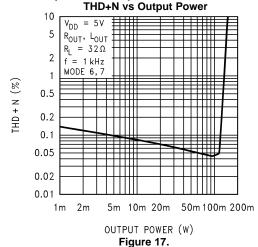


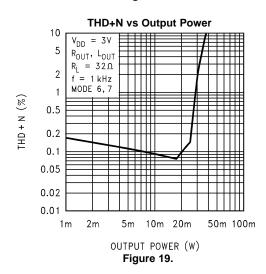


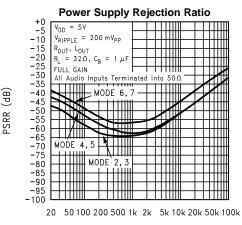






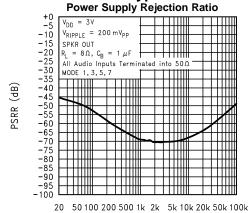




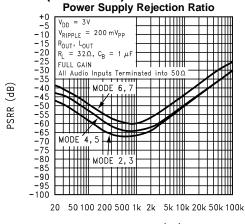


FREQUENCY (Hz) Figure 21.



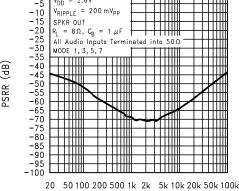


FREQUENCY (Hz) Figure 22.

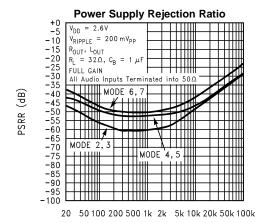


FREQUENCY (Hz)
Figure 23.

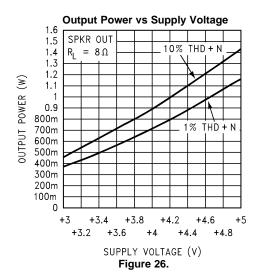


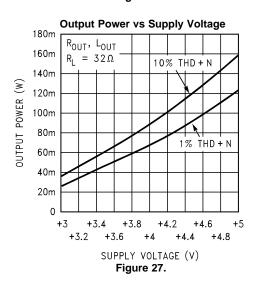


FREQUENCY (Hz)
Figure 24.

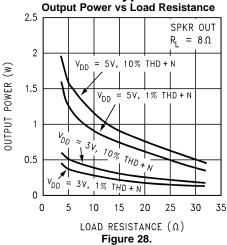


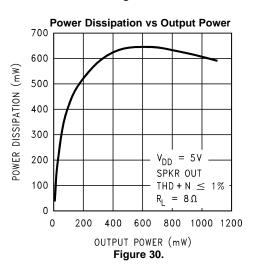
FREQUENCY (Hz) Figure 25.

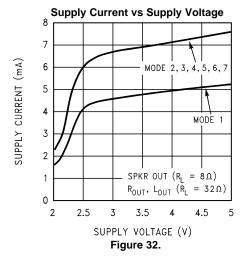


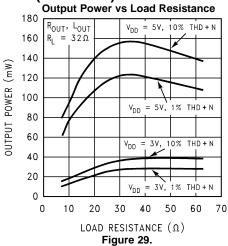


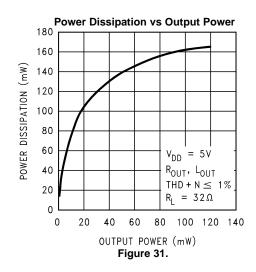












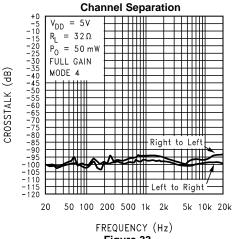
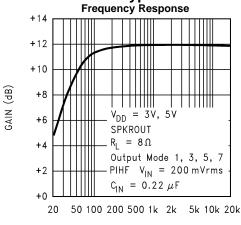
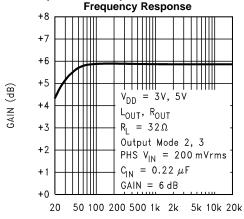


Figure 33.









FREQUENCY (Hz) Figure 34.

FREQUENCY (Hz) Figure 35.

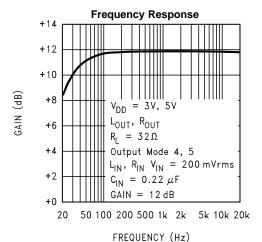


Table 1. Output Noise vs Output Mode  $(V_{DD} = 3V, 5V)^{(1)(2)(3)}$ 

Figure 36.

Output Mode	SPKROUT Output Noise (μV)	LOUT/ROUT Output Noise (μV)
1	29	X
2	Х	28 (G1 = 0dB) 31 (G1 = 6dB)
3	29	28 (G1 = 0dB) 31 (G1 = 6dB)
4	X	28 (G2 = 0dB) 38 (G2 = 12dB)
5	29	28(G2 = 0dB) 38 (G2 = 12dB)
6	Х	38 (G2 = 0dB) 41 (G1 = 0dB) 48 (G1 = 6dB)
7	29	38 (G2 = 0dB) 41 (G1 = 0dB) 48 (G1 = 6dB)

- (1) G1 = gain from P<sub>HS</sub> to LOUT/ROUT (2) G2 = gain from LIN/RIN to LOUT/ROUT
- A weighted filter used

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#### APPLICATION INFORMATION

#### **SPI PIN DESCRIPTION**

DATA: This is the serial data input pin.

CLK: This is the clock input pin.

ENB: This is the SPI enable pin and is active-high.

#### SPI OPERATION DESCRIPTION

The serial data bits are organized into a field which contains 8 bits of data defined by Table 2. The Data 0 to Data 2 bits determine the output mode of the LM4855 as shown in Table 3. The Data 3 to Data 7 bits determine the volume level setting as illustrated by Table 4. For each SPI transfer, the data bits are written to the DATA pin with the least significant bit (LSB) first. All serial data are sampled at the rising edge of the CLK signal. Once all the data bits have been sampled, ENB transitions from logic-high to logic-low to complete the SPI sequence. All 8 bits must be received before any data latch can occur. Any excess CLK and DATA transitions will be ignored after the eighth rising clock edge has occurred. For any data sequence longer than 8 bits, only the first 8 bits will get loaded into the shift register and the rest of the bits will be disregarded.

**Table 2. Bit Allocation** 

Data 0	Mode Select
Data 1	Mode Select
Data 2	Mode Select
Data 3	Volume Control
Data 4	Volume Control
Data 5	Volume Control
Data 6	Volume Control
Data 7	Volume Control

Table 3. Output Mode Selection<sup>(1)</sup>

Output Mode #	Data 2	Data 1	Data 0	SPKR <sub>OUT</sub>	R <sub>OUT</sub>	L <sub>OUT</sub>
0	0	0	0	SD	SD	SD
1	0	0	1	12dB x P <sub>IHF</sub>	SD	SD
2	0	1	0	MUTE	G1 x P <sub>HS</sub>	G1 x P <sub>HS</sub>
3	0	1	1	12dB x P <sub>IHF</sub>	G1 x P <sub>HS</sub>	G1 x P <sub>HS</sub>
4	1	0	0	MUTE	G2 x R	G2 x L
5	1	0	1	12dB x P <sub>IHF</sub>	G2 x R	G2 x L
6	1	1	0 MUTE		(G1 x P <sub>HS</sub> ) + (G2 x R)	(G1 x P <sub>HS</sub> ) + (G2 x L)
7	1	1	1	12dB x P <sub>IHF</sub>	(G1 x P <sub>HS</sub> ) + (G2 x R)	(G1 x P <sub>HS</sub> ) + (G2 x L)

(1) R = Rin

L = Lin

P<sub>IHF</sub> = Phone\_In\_IHF

P<sub>HS</sub> = Phone\_In\_HS

SD = Shutdown Mode

MUTE = Mute Mode

 $G1 = gain from P_{HS} to LOUT/ROUT$ 

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G2 = gain from LIN/ RIN to LOUT/ROUT

Default Mode upon device power-up is Output Mode 0



# **Table 4. Volume Control Settings**

Gain (dB)						
G2	G1					
R <sub>IN</sub> , L <sub>IN</sub> to R <sub>OUT</sub> , L <sub>OUT</sub>	Phone_In_HS to R <sub>OUT</sub> , L <sub>OUT</sub>	Data 7	Data 6	Data 5	Data 4	Data 3
-34.5	-40.5	0	0	0	0	0
-33.0	-39.0	0	0	0	0	1
-31.5	-37.5	0	0	0	1	0
-30.0	-360	0	0	0	1	1
-28.5	-34.5	0	0	1	0	0
-27.0	-33.0	0	0	1	0	1
-25.5	-31.5	0	0	1	1	0
-24.0	-30.0	0	0	1	1	1
-22.5	-28.5	0	1	0	0	0
-21.0	-27.0	0	1	0	0	1
-19.5	-25.5	0	1	0	1	0
-18.0	-24.0	0	1	0	1	1
-16.5	-22.5	0	1	1	0	0
-15.0	-21.0	0	1	1	0	1
-13.5	-19.5	0	1	1	1	0
-12.0	-18.0	0	1	1	1	1
-10.5	-16.5	1	0	0	0	0
-9.0	-15.0	1	0	0	0	1
-7.5	-13.5	1	0	0	1	0
-6.0	-12.0	1	0	0	1	1
-4.5	-10.5	1	0	1	0	0
-3.0	-9.0	1	0	1	0	1
-1.5	-7.5	1	0	1	1	0
0.0	-6.0	1	0	1	1	1
1.5	-4.5	1	1	0	0	0
3.0	-3.0	1	1	0	0	1
4.5	-1.5	1	1	0	1	0
6.0	0	1	1	0	1	1
7.5	1.5	1	1	1	0	0
9.0	3.0	1	1	1	0	1
10.5	4.5	1	1	1	1	0
12.0	6.0	1	1	1	1	1



#### SPI OPERATIONAL REQUIREMENTS

- 1. The data bits are transmitted with the LSB first.
- 2. The maximum clock rate is 10MHz for the CLK pin.
- 3. CLK must remain logic-high for at least 50ns ( $t_{CH}$ ) after the rising edge of CLK, and CLK must remain logic-low for at least 50ns ( $t_{CL}$ ) after the falling edge of CLK.
- 4. The serial data bits are sampled at the rising edge of CLK. Any transition on DATA must occur at least 20ns ( $t_{DS}$ ) before the rising edge of CLK. Also, any transition on DATA must occur at least 20ns ( $t_{DH}$ ) after the rising edge of CLK and stabilize before the next rising edge of CLK.
- 5. ENB should be logic-high only during serial data transmission.
- 6. ENB must be logic-high at least 20ns ( $t_{ES}$ ) before the first rising edge of CLK, and ENB has to remain logic-high at least 20ns ( $t_{EH}$ ) after the eighth rising edge of CLK.
- 7. If ENB remains logic-low for more than 10ns before all 8 bits are transmitted then the data latch will be aborted.
- 8. If ENB is logic-high for more than 8 CLK pulses then only the first 8 data bits will be latched and activated when ENB transitions to logic-low.
- 9. ENB must remain logic-low for at least 30ns (t<sub>EL</sub>) to latch in the data.
- 10. Coincidental rising or falling edges of CLK and ENB are not allowed. If CLK is to be held logic-high after the data transmission, the falling edge of CLK must occur at least 20ns ( $t_{CS}$ ) before ENB transitions to logic-high for the next set of data.

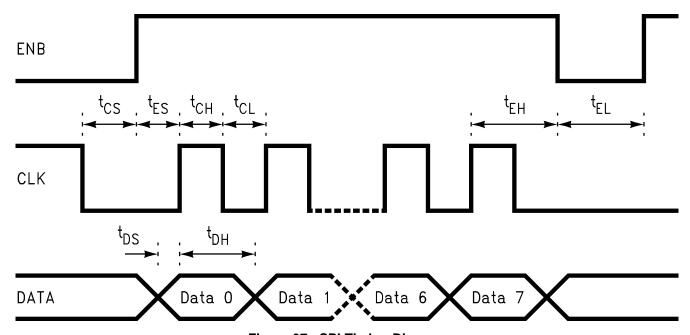


Figure 37. SPI Timing Diagram

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#### **EXPOSED-DAP MOUNTING CONSIDERATIONS**

The LM4855's exposed-DAP (die attach paddle) package (NHW) provides a low thermal resistance between the die and the PCB to which the part is mounted and soldered. This allows rapid heat transfer from the die to the surrounding PCB copper area heatsink, copper traces, ground plane, and finally, surrounding air. The result is a low voltage audio power amplifier that produces 1.1W dissipation in a 8Ω load at ≤ 1% THD+N. This high power is achieved through careful consideration of necessary thermal design. Failing to optimize thermal design may compromise the LM4855's high power performance and activate unwanted, though necessary, thermal shutdown protection.

The NHW package must have its DAP soldered to a copper pad on the PCB. The DAP's PCB copper pad is then, ideally, connected to a large plane of continuous unbroken copper. This plane forms a thermal mass, heat sink, and radiation area. Place the heat sink area on either outside plane in the case of a two-sided or multi-layer PCB. (The heat sink area can also be placed on an inner layer of a multi-layer board. The thermal resistance, however, will be higher.) Connect the DAP copper pad to the inner layer or backside copper heat sink area with 6 (3 X 2) (NHW) vias. The via diameter should be 0.012in - 0.013in with a 1.27mm pitch. Ensure efficient thermal conductivity by plugging and tenting the vias with plating and solder mask, respectively.

Best thermal performance is achieved with the largest practical copper heat sink area. If the heatsink and amplifier share the same PCB layer, a nominal  $2.5 \text{in}^2$  (min) area is necessary for 5V operation with a  $4\Omega$  load. Heatsink areas not placed on the same PCB layer as the LM4855 should be  $5 \text{in}^2$  (min) for the same supply voltage and load resistance. The last two area recommendations apply for  $25^{\circ}\text{C}$  ambient temperature. Increase the area to compensate for ambient temperatures above  $25^{\circ}\text{C}$ . In all circumstances and under all conditions, the junction temperature must be held below  $150^{\circ}\text{C}$  to prevent activating the LM4855's thermal shutdown protection. Further detailed and specific information concerning PCB layout and fabrication and mounting an NHW (WQFN) is found in Tl's AN1187.

# PCB LAYOUT AND SUPPLY REGULATION CONSIDERATIONS FOR DRIVING 3 $\Omega$ AND 4 $\Omega$ LOADS

Power dissipated by a load is a function of the voltage swing across the load and the load's impedance. As load impedance decreases, load dissipation becomes increasingly dependent on the interconnect (PCB trace and wire) resistance between the amplifier output pins and the load's connections. Residual trace resistance causes a voltage drop, which results in power dissipated in the trace and not in the load as desired. For example,  $0.1\Omega$  trace resistance reduces the output power dissipated by a  $4\Omega$  load from 1.7W to 1.6W. The problem of decreased load dissipation is exacerbated as load impedance decreases. Therefore, to maintain the highest load dissipation and widest output voltage swing, PCB traces that connect the output pins to a load must be as wide as possible.

Poor power supply regulation adversely affects maximum output power. A poorly regulated supply's output voltage decreases with increasing load current. Reduced supply voltage causes decreased headroom, output signal clipping, and reduced output power. Even with tightly regulated supplies, trace resistance creates the same effects as poor supply regulation. Therefore, making the power supply traces as wide as possible helps maintain full output voltage swing.

#### **BRIDGE CONFIGURATION EXPLANATION**

As shown in Figure 1, the LM4855 consists of three pairs of output amplifier blocks (A4-A6). A4, A5, and A6 consist of bridged-tied amplifier pairs that drive LOUT, ROUT, and SPKROUT respectively. The LM4855 drives a load, such as a speaker, connected between outputs, SPKROUT+ and SPKROUT-. In the amplifier block A6, the output of the amplifier that drives SPKROUT- serves as the input to the unity gain inverting amplifier that drives SPKROUT+.

This results in both amplifiers producing signals identical in magnitude, but 180° out of phase. Taking advantage of this phase difference, a load is placed between SPKROUT- and SPKROUT+ and driven differentially (commonly referred to as 'bridge mode'). This results in a differential or BTL gain of:

$$A_{VD} = 2(R_f/R_i) = 2$$
 (1)



Bridge mode amplifiers are different from single-ended amplifiers that drive loads connected between a single amplifier's output and ground. For a given supply voltage, bridge mode has a distinct advantage over the single-ended configuration: its differential output doubles the voltage swing across the load. Theoretically, this produces four times the output power when compared to a single-ended amplifier under the same conditions. This increase in attainable output power assumes that the amplifier is not current limited and that the output signal is not clipped.

Another advantage of the differential bridge output is no net DC voltage across the load. This is accomplished by biasing SPKROUT- and SPKROUT+ outputs at half-supply. This eliminates the coupling capacitor that single supply, single-ended amplifiers require. Eliminating an output coupling capacitor in a typical single-ended configuration forces a single-supply amplifier's half-supply bias voltage across the load. This increases internal IC power dissipation and may permanently damage loads such as speakers.

#### **POWER DISSIPATION**

Power dissipation is a major concern when designing a successful single-ended or bridged amplifier.

A direct consequence of the increased power delivered to the load by a bridge amplifier is higher internal power dissipation. The LM4855 has a pair of bridged-tied amplifiers driving a handsfree speaker, SPKROUT. The maximum internal power dissipation operating in the bridge mode is twice that of a single-ended amplifier. From Equation (2), assuming a 5V power supply and an  $8\Omega$  load, the maximum SPKROUT power dissipation is 634mW.

$$P_{\text{DMAX-SPKROLIT}} = 4(V_{\text{DD}})^2/(2\pi^2 R_{\text{I}}): \text{ Bridge Mode}$$
 (2)

The LM4855 also has 2 pairs of bridged-tied amplifiers driving stereo headphones, ROUT and LOUT. The maximum internal power dissipation for ROUT and LOUT is given by equation (3) and (4). From Equations (3) and (4), assuming a 5V power supply and a  $32\Omega$  load, the maximum power dissipation for LOUT and ROUT is 158mW, or 316mW total.

$$P_{DMAX-LOUT} = 4(V_{DD})^2/(2\pi^2 R_L): Bridge Mode$$
 (3)

$$P_{\text{DMAX-ROUT}} = 4(V_{\text{DD}})^2/(2\pi^2 R_{\text{L}}): \text{ Bridge Mode}$$
(4)

The maximum internal power dissipation of the LM4855 occurs when all 3 amplifiers pairs are simultaneously on; and is given by Equation (5).

$$P_{DMAX-TOTAL} = P_{DMAX-SPKROUT} + P_{DMAX-LOUT} + P_{DMAX-ROUT}$$
(5)

The maximum power dissipation point given by Equation (5) must not exceed the power dissipation given by Equation (6):

$$P_{DMAX}' = (T_{JMAX} - T_A)/\theta_{JA}$$
(6)

The LM4855's TJMAX = 150°C. In the YZR package, the LM4855's  $\theta_{JA}$  is 48°C/W. In the NHW package soldered to a DAP pad that expands to a copper area of  $2.5 \text{in}^2$  on a PCB, the LM4855's  $\theta_{JA}$  is 42°C/W. At any given ambient temperature  $T_A$ , use Equation (6) to find the maximum internal power dissipation supported by the IC packaging. Rearranging Equation (6) and substituting  $P_{DMAX-TOTAL}$  for  $P_{DMAX}$  results in Equation (7). This equation gives the maximum ambient temperature that still allows maximum stereo power dissipation without violating the LM4855's maximum junction temperature.



$$T_{A} = T_{JMAX} - P_{DMAX-TOTAL}\theta_{JA}$$
 (7)

For a typical application with a 5V power supply and an  $8\Omega$  load, the maximum ambient temperature that allows maximum stereo power dissipation without exceeding the maximum junction temperature is approximately 104°C for the YZR package.

$$T_{\text{JMAX}} = P_{\text{DMAX-TOTAL}} \theta_{\text{JA}} + T_{\text{A}} \tag{8}$$

Equation (8) gives the maximum junction temperature  $T_{JMAX}$ . If the result violates the LM4855's 150°C, reduce the maximum junction temperature by reducing the power supply voltage or increasing the load resistance. Further allowance should be made for increased ambient temperatures.

The above examples assume that a device is a surface mount part operating around the maximum power dissipation point. Since internal power dissipation is a function of output power, higher ambient temperatures are allowed as output power or duty cycle decreases. If the result of Equation (5) is greater than that of Equation (6), then decrease the supply voltage, increase the load impedance, or reduce the ambient temperature. If these measures are insufficient, a heat sink can be added to reduce  $\theta_{JA}$ . The heat sink can be created using additional copper area around the package, with connections to the ground pin(s), supply pin and amplifier output pins. External, solder attached SMT heatsinks such as the Thermalloy 7106D can also improve power dissipation. When adding a heat sink, the  $\theta_{JA}$  is the sum of  $\theta_{JC}$ ,  $\theta_{CS}$ , and  $\theta_{SA}$ . ( $\theta_{JC}$  is the junction-to-case thermal impedance,  $\theta_{CS}$  is the case-to-sink thermal impedance, and  $\theta_{SA}$  is the sink-to-ambient thermal impedance.) Refer to the Typical Performance Characteristics curves for power dissipation information at lower output power levels.

#### POWER SUPPLY BYPASSING

As with any power amplifier, proper supply bypassing is critical for low noise performance and high power supply rejection. Applications that employ a 5V regulator typically use a  $10\mu\text{F}$  in parallel with a  $0.1\mu\text{F}$  filter capacitors to stabilize the regulator's output, reduce noise on the supply line, and improve the supply's transient response. However, their presence does not eliminate the need for a local  $1.0\mu\text{F}$  tantalum bypass capacitance connected between the LM4855's supply pins and ground. Keep the length of leads and traces that connect capacitors between the LM4855's power supply pin and ground as short as possible. Connecting a  $1\mu\text{F}$  capacitor,  $C_B$ , between the BYPASS pin and ground improves the internal bias voltage's stability and improves the amplifier's PSRR. The PSRR improvements increase as the bypass pin capacitor value increases. Too large, however, increases turn-on time and can compromise the amplifier's click and pop performance. The selection of bypass capacitor values, especially  $C_B$ , depends on desired PSRR requirements, click and pop performance (as explained in the section Selecting External Components) system cost, and size constraints.

#### **SELECTING EXTERNAL COMPONENTS**

#### Input Capacitor Value Selection

Amplifying the lowest audio frequencies requires high value input coupling capacitor ( $C_i$  in Figure 1). A high value capacitor can be expensive and may compromise space efficiency in portable designs. In many cases, however, the speakers used in portable systems, whether internal or external, have little ability to reproduce signals below 150Hz. Applications using speakers with this limited frequency response reap little improvement by using large input capacitor.

The internal input resistor  $(R_i)$  and the input capacitor  $(C_i)$  produce a high pass filter cutoff frequency that is found using Equation (9).

$$f_c = 1 / (2\pi R_i C_i) \tag{9}$$

As an example when using a speaker with a low frequency limit of 150Hz,  $C_i$ , using Equation (9) is 0.063 $\mu$ F. The 0.22 $\mu$ F  $C_i$  shown in Figure 1 allows the LM4855 to drive high efficiency, full range speaker whose response extends below 40Hz.

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#### **Bypass Capacitor Value Selection**

Besides minimizing the input capacitor size, careful consideration should be paid to value of  $C_B$ , the capacitor connected to the BYPASS pin. Since  $C_B$  determines how fast the LM4855 settles to quiescent operation, its value is critical when minimizing turn-on pops. The slower the LM4855's outputs ramp to their quiescent DC voltage (nominally  $V_{DD}/2$ ), the smaller the turn-on pop. Choosing  $C_B$  equal to  $1.0\mu F$  along with a small value of  $C_i$  (in the range of  $0.1\mu F$  to  $0.39\mu F$ ), produces a click-less and pop-less shutdown function. As discussed above, choosing  $C_i$  no larger than necessary for the desired bandwidth helps minimize clicks and pops.  $C_B$ 's value should be in the range of 5 times to 7 times the value of  $C_i$ . This ensures that output transients are eliminated when power is first applied or the LM4855 resumes operation after shutdown.

### **Demonstration Board Layout**

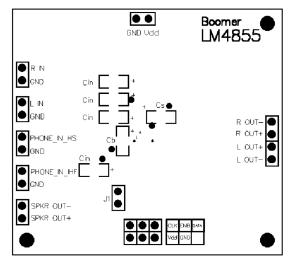


Figure 38. Recommended YZR PC Board Layout: Top Silkscreen

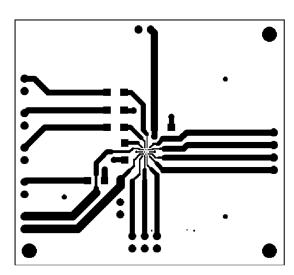


Figure 39. Recommended YZR PC Board Layout: Top Layer

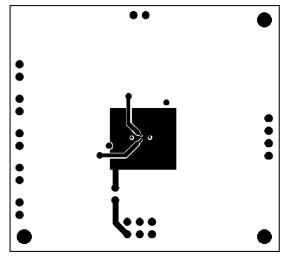


Figure 40. Recommended YZR PC Board Layout: Middle Layer

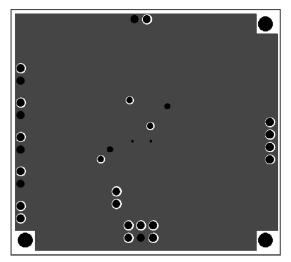


Figure 41. Recommended YZR PC Board Layout:
Bottom Layer



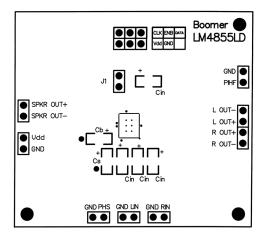


Figure 42. Recommended NHW PC Board Layout: Top Silkcreen Layer

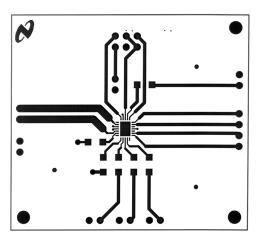


Figure 43. Recommended NHW PC Board Layout: **Top Layer** 

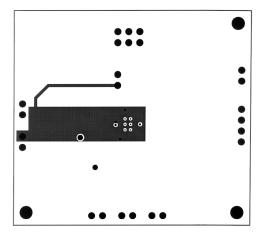


Figure 44. Recommended NHW PC Board Layout: Inner Layer 1

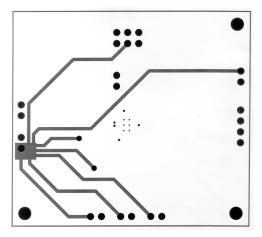


Figure 45. Recommended NHW PC Board Layout: Inner Layer 2

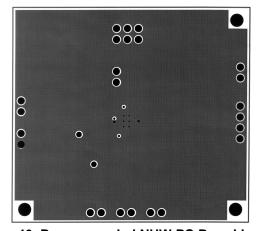


Figure 46. Recommended NHW PC Board Layout: **Bottom Layer** 





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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
LM4855ITL/NOPB	ACTIVE	DSBGA	YZR	18	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	G A9	Samples
LM4855ITLX/NOPB	ACTIVE	DSBGA	YZR	18	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	G A9	Samples
LM4855LQ/NOPB	ACTIVE	WQFN	NHW	24	1000	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 85	L4855LQ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

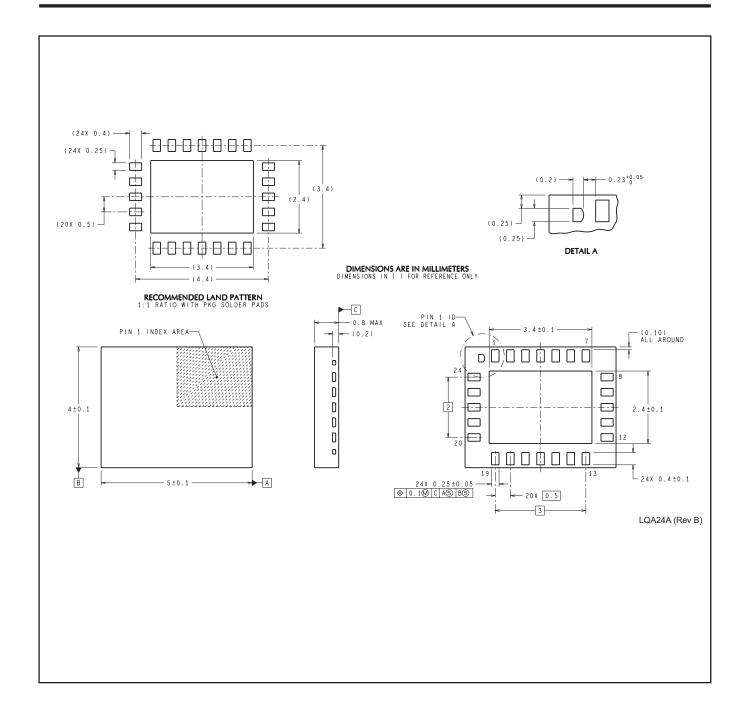
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

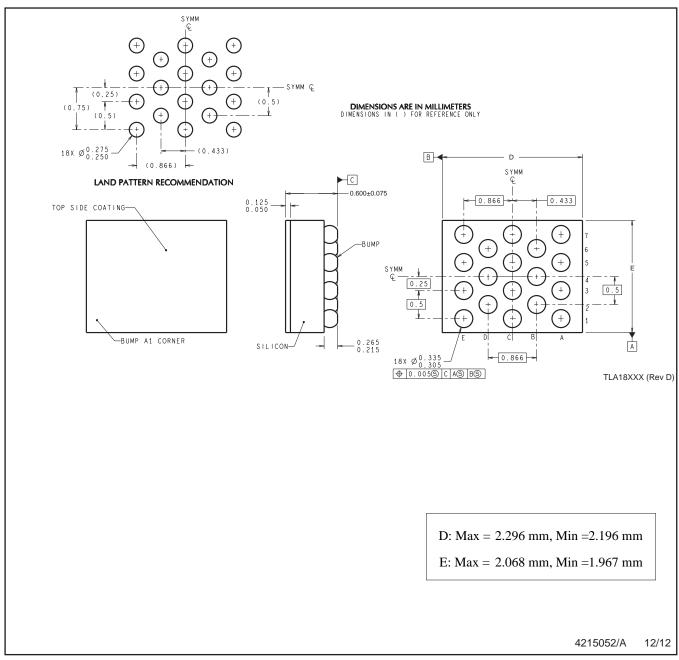
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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<sup>&</sup>lt;sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. B. This drawing is subject to change without notice.



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